

<b>Notice of References Cited</b>	Application/Control No. 09/993,856	Applicant(s)/Patent Under Reexamination JAHN, MARGARET M.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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Applicant(s)/Patent Under

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JAHN, MARGARET M.

Examiner

Anne R. Kubelik

Art Unit

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